

# GSM2343A

## 20V P-Channel Enhancement Mode MOSFET

### Product Description

GSM2343A, P-Channel enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent  $R_{DS(ON)}$ , low gate charge.

These devices are particularly suited for low voltage power management, such as smart phone and notebook computer and other battery powered circuits, and low in-line power loss are needed in commercial industrial surface mount applications.

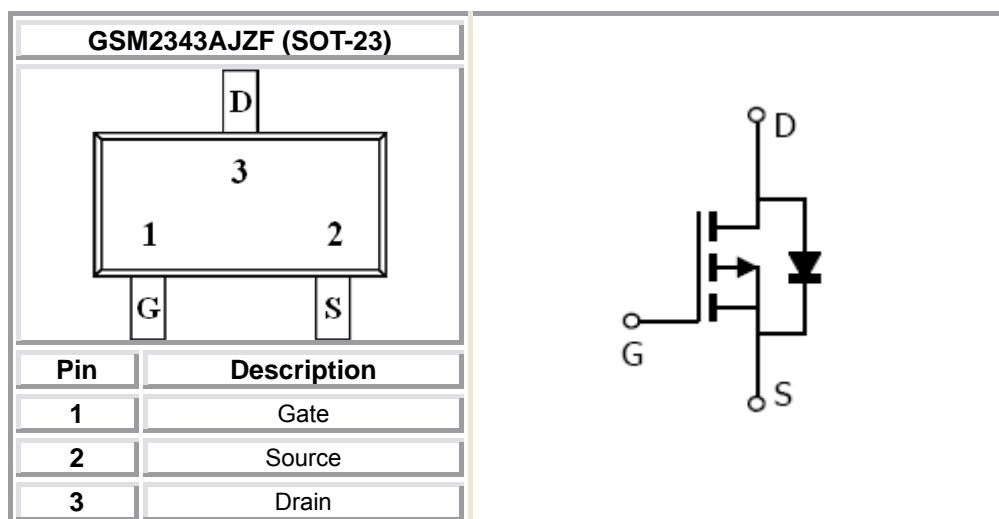
### Features

- -20V/-2.8A,  $R_{DS(ON)}=70m\Omega$  @  $V_{GS}=-4.5V$
- -20V/-2.4A,  $R_{DS(ON)}=92m\Omega$  @  $V_{GS}=-2.5V$
- -20V/-2.0A,  $R_{DS(ON)}=180m\Omega$  @  $V_{GS}=-1.8V$
- Super high density cell design for extremely low  $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability

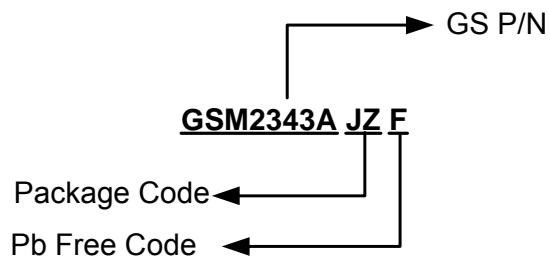
### Applications

- Portable Equipment
- Battery Powered System
- Net Working System

### Packages & Pin Assignments

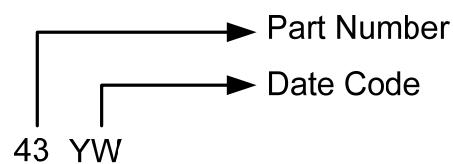


## Ordering Information



Part Number	Package	Quantity Reel
GSM2343AJZF	SOT-23	3000 PCS

## Marking Information



## Absolute Maximum Ratings

( $T_A=25^\circ\text{C}$  unless otherwise noted)

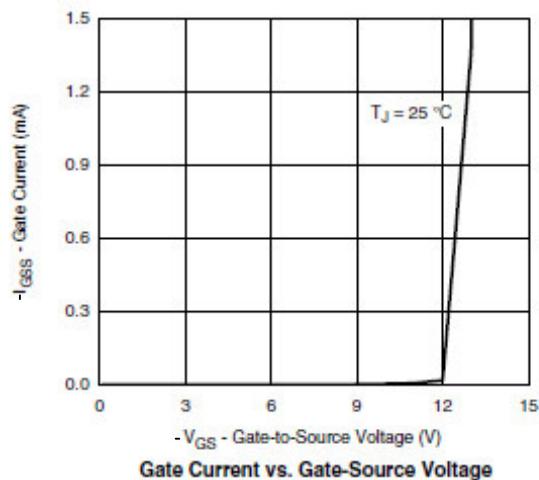
Symbol	Parameter	Typical	Unit	
$V_{DSS}$	Drain-Source Voltage	-20	V	
$V_{GSS}$	Gate -Source Voltage	$\pm 12$	V	
$I_D$	Continuous Drain Current( $T_J=150^\circ\text{C}$ )	$T_A=25^\circ\text{C}$	-2.8	A
		$T_A=70^\circ\text{C}$	-2.4	
$I_{DM}$	Pulsed Drain Current	-10	A	
$I_S$	Continuous Source Current(Diode Conduction)	-1.6	A	
$P_D$	Power Dissipation	$T_A=25^\circ\text{C}$	1.25	W
		$T_A=70^\circ\text{C}$	0.8	
$T_J$	Operating Junction Temperature	150	$^\circ\text{C}$	
$T_{STG}$	Storage Temperature Range	-55/150	$^\circ\text{C}$	
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	120	$^\circ\text{C}/\text{W}$	

## Electrical Characteristics

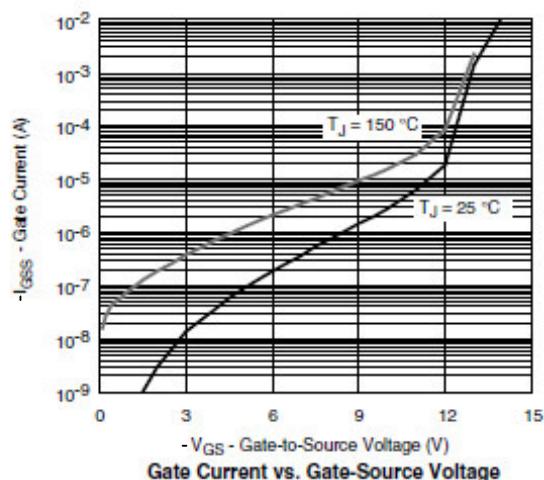
( $T_A=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static</b>						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=-250\mu\text{A}$	-20			V
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-0.4		-1.0	
$I_{GSS}$	Gate Leakage Current	$V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$			$\pm 100$	nA
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-16\text{V}, V_{GS}=0\text{V}$			-1	uA
		$V_{DS}=-16\text{V}, V_{GS}=0\text{V}, T_J=85^\circ\text{C}$			-10	
$I_{D(\text{on})}$	On-State Drain Current	$V_{DS} \leq -5\text{V}, V_{GS}=-4.5\text{V}$	-6			A
		$V_{DS} \leq -5\text{V}, V_{GS}=-2.5\text{V}$	-4			
$R_{DS(\text{on})}$	Drain-Source On-Resistance	$V_{GS}=-4.5\text{V}, I_D=-2.8\text{A}$		63	70	mΩ
		$V_{GS}=-2.5\text{V}, I_D=-2.4\text{A}$		84	92	
		$V_{GS}=-1.8\text{V}, I_D=-2.0\text{A}$		165	180	
$g_{FS}$	Forward Transconductance	$V_{DS}=-5\text{V}, I_D=-3.6\text{A}$		10		S
$V_{SD}$	Diode Forward Voltage	$I_S=-1.6\text{A}, V_{GS}=0\text{V}$		-0.85	-1.2	V
<b>Dynamic</b>						
$C_{iss}$	Input Capacitance	$V_{DS}=-10\text{V}, V_{GS}=0\text{V}, f=1\text{MHz}$		780		pF
$C_{oss}$	Output Capacitance			115		
$C_{rss}$	Reverse Transfer Capacitance			55		
$Q_g$	Total Gate Charge	$V_{DS}=-10\text{V}, V_{GS}=-4.5\text{V}, I_D=-4.0\text{A}$		8.0	12	nC
$Q_{qs}$	Gate-Source Charge			0.9		
$Q_{qd}$	Gate-Drain Charge			3.0		
$t_{d(on)}$	Turn-On Time	$V_{DD}=-10\text{V}, R_L=2.3\Omega, I_D=-4.0\text{A}, V_{GEN}=-4.5\text{V}, R_G=1\Omega$		0.2	0.3	us
$t_r$				1.0	1.5	
$t_{d(off)}$	Turn-Off Time			4.0	6.0	
$t_f$				2.0	3.0	

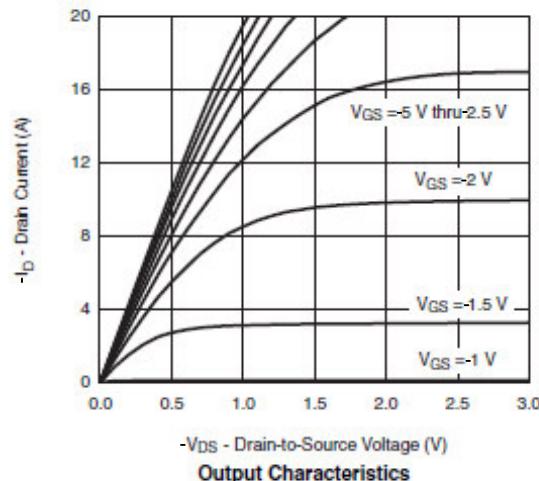
## Typical Performance Characteristics



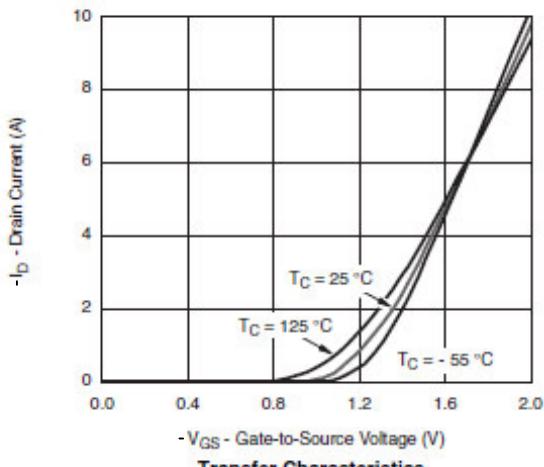
Gate Current vs. Gate-Source Voltage



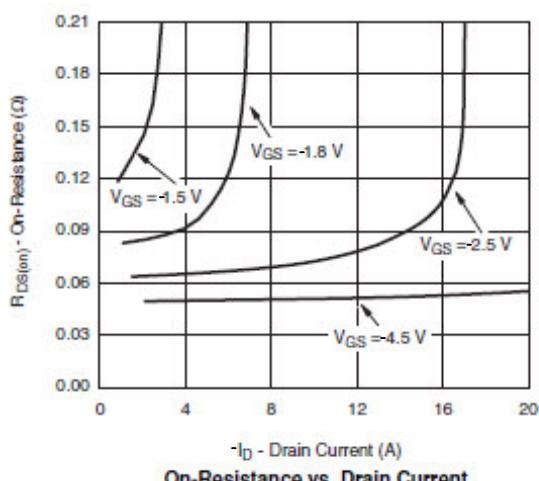
Gate Current vs. Gate-Source Voltage



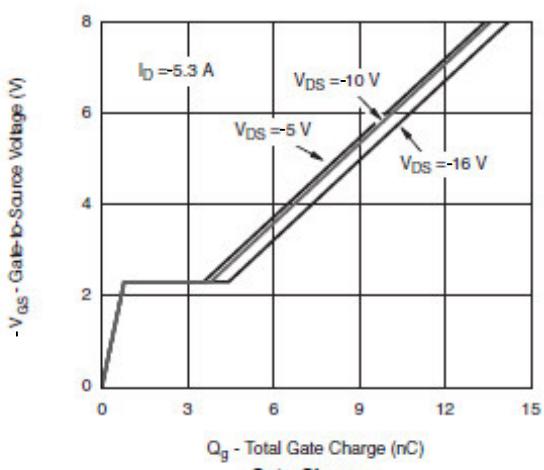
Output Characteristics



Transfer Characteristics

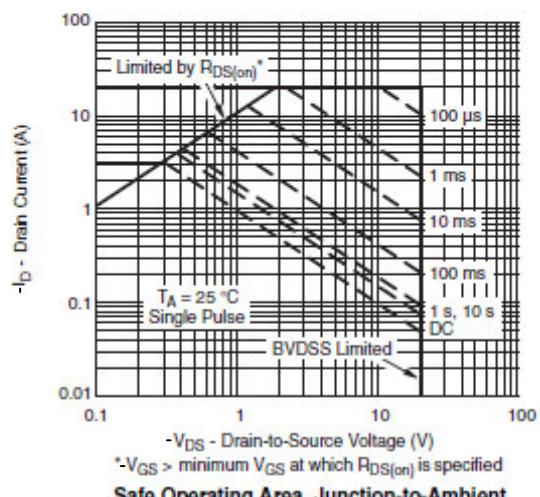
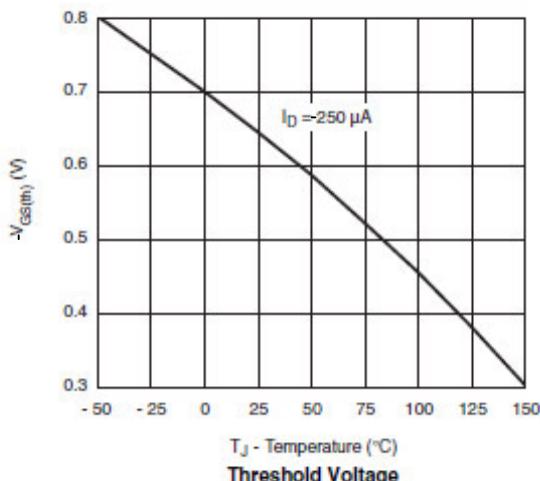
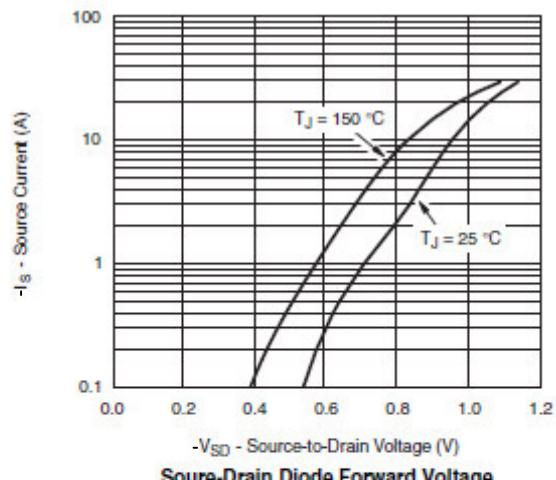
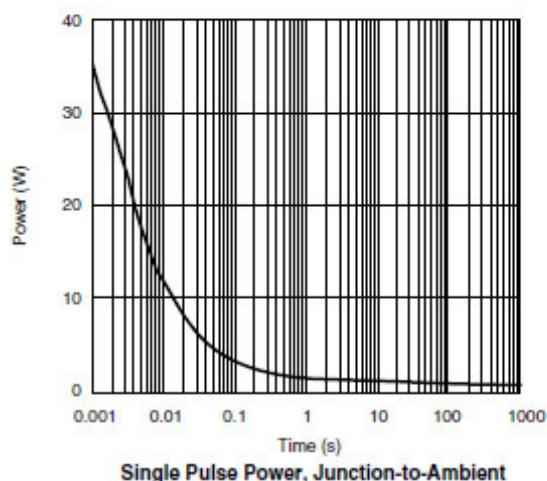
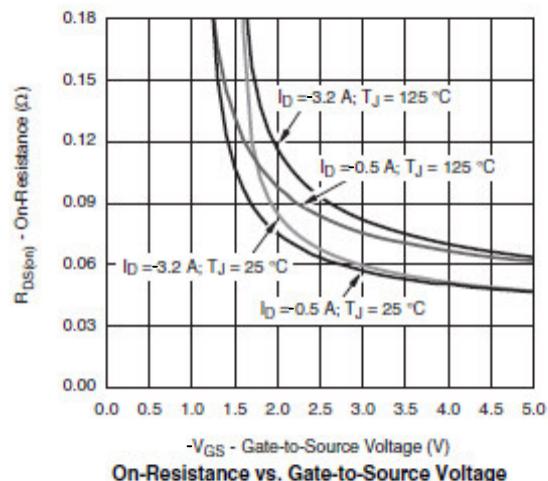
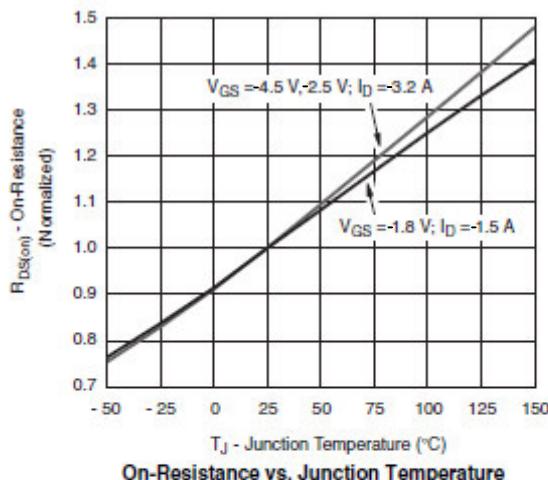


On-Resistance vs. Drain Current



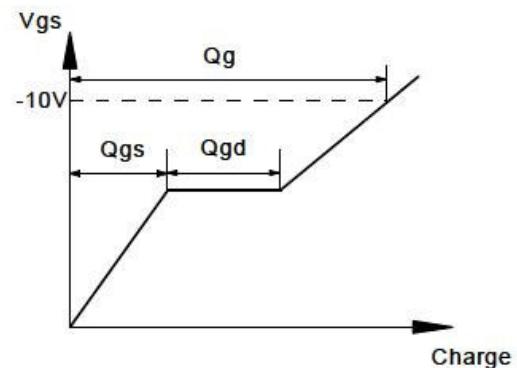
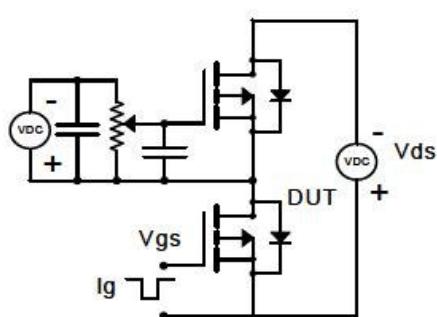
Gate Charge

## Typical Performance Characteristics (continue)

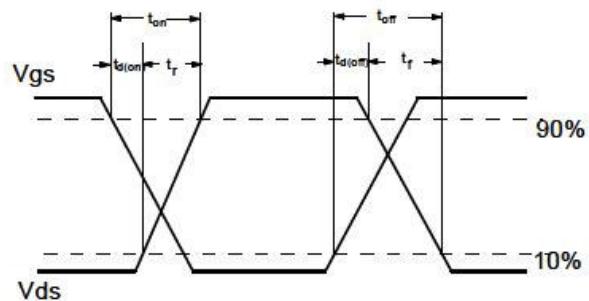
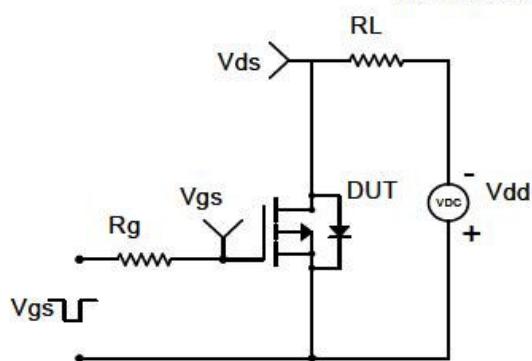


## Typical Performance Characteristics (continue)

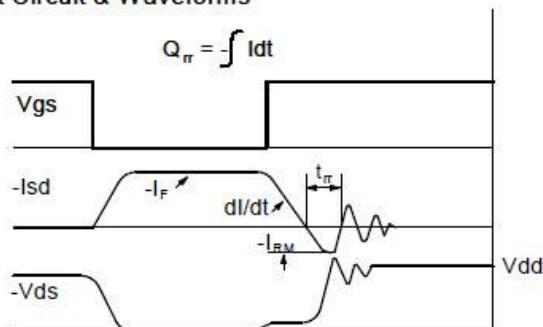
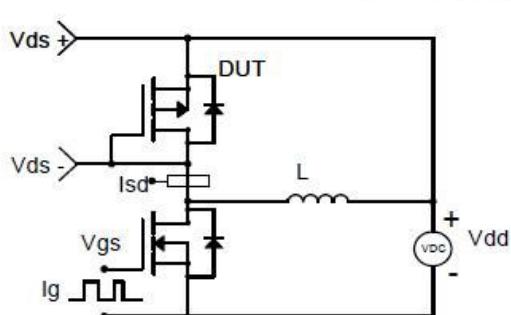
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms

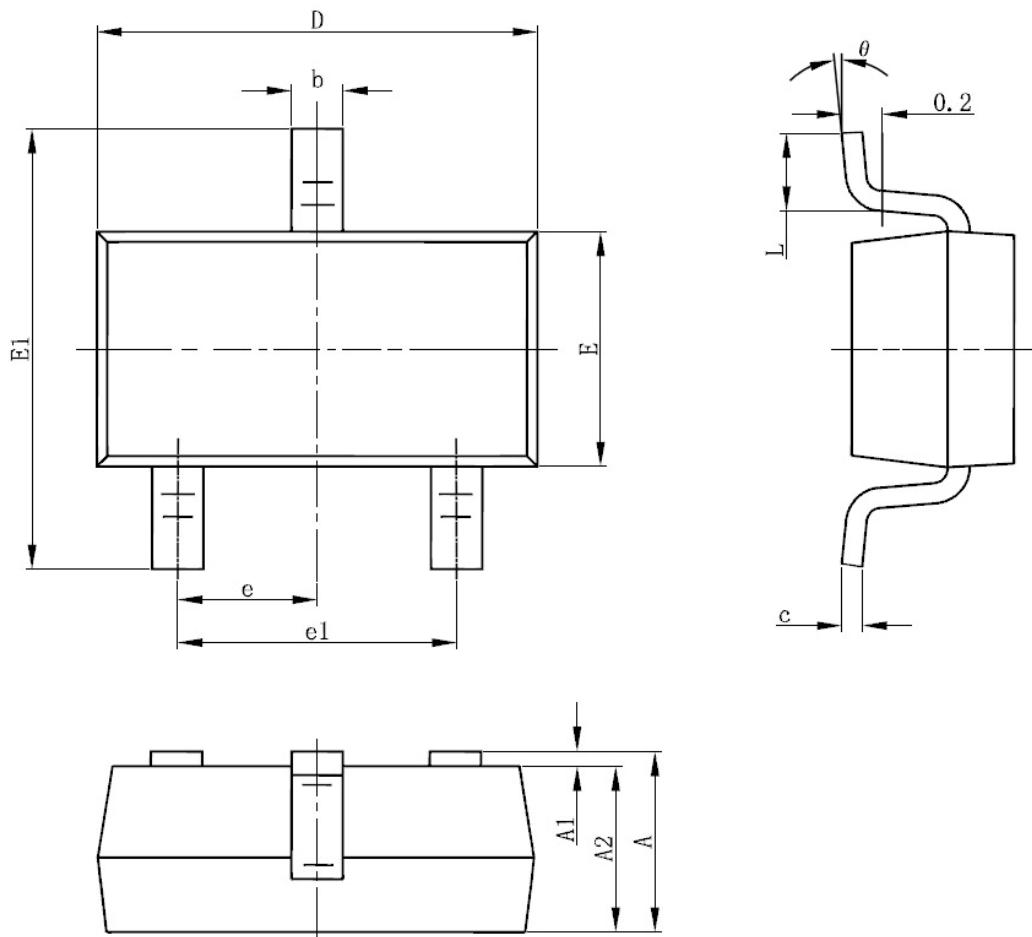


Diode Recovery Test Circuit & Waveforms



## Package Dimension

### SOT-23 PLASTIC PACKAGE



#### Dimensions

SYMBOL	Millimeters		Inches	
	MIN	MAX	MIN	MAX
A	0.9	1.2	0.035	0.043
A1	0	0.1	0	0.004
A2	0.9	1.1	0.035	0.039
b	0.3	0.5	0.012	0.020
c	0.08	0.15	0.003	0.006
D	2.8	3	0.110	0.118
E	1.2	1.4	0.047	0.055
E1	2.25	2.55	0.089	0.100
e	0.950 TYP		0.037 TYP	
e1	1.8	2	0.071	0.079
L	0.55REF		0.022REF	
L1	0.3	0.5	0.012	0.020
Q	0°	8°	0°	6°

GSM2343A

## NOTICE

Information furnished is believed to be accurate and reliable. However Globaltech Semiconductor assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties, which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Globaltech Semiconductor. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information without express written approval of Globaltech Semiconductor.

## CONTACT US

### GS Headquarter

	4F.,No.43-1,Lane11,Sec.6,Minquan E.Rd Neihu District Taipei City 114, Taiwan (R.O.C)
	886-2-2657-9980
	886-2-2657-3630
	<a href="mailto:sales_twn@gs-power.com">sales_twn@gs-power.com</a>

### Wu-Xi Branch

	No.21 Changjiang Rd., WND, Wuxi, Jiangsu, China (INFO. & TECH. Science Park Building A 210 Room)
	86-510-85217051
	86-510-85211238
	<a href="mailto:sales_cn@gs-power.com">sales_cn@gs-power.com</a>

### RD Division

	824 Bolton Drive Milpitas. CA. 95035
	1-408-457-0587